

Search Notes



Application/Control No.

10/049,626

Examiner

Frank W. Lu

Applicant(s)/Patent under Reexamination

MARUYAMA ET AL.

Art Unit

1634

SEARCHED

Class	Subclass	Date	Examiner.
435	6 1.31 1.32	8/5/2005	~
	1.33		
	1.34		
	1.35		
	1.36		
	1.37		
	91.1		
	91.2		
	183		
436	94		
536	23.1		
	24.3		
	24.33		
	253		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

STN	DATE	EXMR
East (see attached file)	8/5/2005	~
Inventor Searches		